

Search Notes**Application/Control No.**

10/795,767

Examiner

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Applicant(s)/Patent under Reexamination

MADOCH ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	219 220.01 221.01 221.08- 221.1	7/9/2005	BQT
	221.15		
	229 230		
	207.02		
Updated	Search	12/12/2005	BQT
Updated	Search	4/22/2006	BQT
Updated	Search	8/4/2006	BQT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/9/2005	BQT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner